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Form PTO 1449A U.S. Department of Commerce Patent and Trademark Office Information Disclosure Statement by Applicant	ATTY. DOCKET NUMBER: 78384 (18-32 US DIV1)	SERIAL NUMBER: 10/706,142	
	APPLICANT: PHILLIPS ET AL		
	FILING DATE: GROUP:		
	11/12/2003	1732	

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILE APE
	3,338,730	Aug 29, 1967	Slade et al.	428	142	
	4,168,983	Sep 25, 1979	Vittands et al.	106	14.12	
	4,310,584	Jan 12, 1982	Cooper et al	428	212	
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Foreign Patent Documents

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						Yzs	No
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	1696245	Jan 13, 1972	DE	D21H	5/10		No
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	0698256	Oct 22, 1997	EP	G06K	19/14		
			Dura Concessor				****

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DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
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	Definition of "directly" from	Webster's Third New International Dictionary, 1993, pg. 641			
EXAMINER	/Mathieu Vargot/	DATE CONSIDERED 02/24/2010			
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